

### 12500 TI Boulevard, MS 8640, Dallas, Texas 75243

# PCN# 20140701000 Qualification of CK5000A Mold Compound in AP1 for PDIP packages Change Notification / Sample Request

#### Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The changes discussed within this PCN will not take effect any earlier than **90** days from the date of this notification, unless customer agreement has been reached on an earlier implementation of the change. This notification period is per TI's standard process.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (<u>PCN\_ww\_admin\_team@list.ti.com</u>).

Sincerely,

PCN Team SC Business Services Phone: +1(214) 480-6037 Fax: +1(214) 480-6659

# PCN# 20140701000 Attachment: 1

### **Products Affected:**

According to our records, there are the affected device(s) that you have purchased within the past twenty-four (24) months. Technical details of this Product Change follow on the next page(s).

Title: Qualification of CK5000A Mold Compound in AP1 for PDIP packages							
Customer Contact:PCN ManagerPhone:+1(214)480-6037Dept:Quality Service	es						
Proposed 1 <sup>st</sup> Ship Date: 10/10/2014 Estimated Sample Availability: Date Provided at Sample request							
Change Type:							
Assembly Site Design Wafer Bump Site							
Assembly Process Data Sheet Wafer Bump Material							
	Wafer Bump Process						
✓ Mechanical Specification       ✓ Test Site       ✓ Wafer Fab Site         ✓ Packing/Shipping/Labeling       ✓ Test Process       ✓ Wafer Fab Materials							
Packing/Shipping/Labeling   Pest Process   Water Fab Materials   Wafer Fab Process							
PCN Details							
Description of Change:							
Texas Instruments Incorporated is announcing the Qualification of CK5000A Mold Compound in Amkor Philippines (AP1) for PDIP packages.  Change From: Change To:							
Mold Compound DMC2000HG, DMC200NF CK5000A							
Reason for Change:							
Discontinuation of DMC2000HG & DMC200NF mold compound by Amkor Philippines (AP1).							
Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative)	:						
None							
Changes to product identification resulting from this PCN:							
None							
Product Affected:							
ADC0831CCN/NOPB DS75176BN/NOPB LM2574HVN-ADJ/NOPB LM6144BIN/NOPB							
ADC0832CCN/NOPB DS75176BTN/NOPB LM2574N-12/NOPB LM78S40N/NOPB							
ADC0834CCN/NOPB DS96174CN LM2574N-3.3/NOPB LMC6041IN/NOPB							
AM26LS31PC DS96174CN/NOPB LM2574N-5.0 LMC6042AIN/NOPB							
DS14C88N							
DS14C89AN DS96176CN/NOPB LM2574N-ADJ/NOPB LMC6462BIN/NOPB							
DS14C89AN/NOPB LF353N/NOPB LM2578AN/NOPB LMC6464BIN/NOPB							
DS26C31TN							
DS26C31TN/NOPB LF412ACN/NOPB LM2672N-5.0/NOPB LMC6484IN							
DS26LS31CN LF412CN/NOPB LM2674N-ADJ/NOPB LMC6484IN/NOPB							
DS26LS31CN/NOPB LHV720NA/NOPB LM2675N-ADJ/NOPB LMC660AIN/NOPB							
DS26LS31N         LM13700N/NOPB         LM2902N/NOPB         LMC660CN/NOPB           DS3658N         LM2524DN         LM318N         LME49740NA/NOPB							
DS3658N         LM2524DN         LM318N         LME49740NA/NOPB           DS3658N/NOPB         LM2524DN/NOPB         LM318N/NOPB         TP3054N/NOPB							
DS3668N/NOPB							
DS3695N/NOPB							
DS3695TN/NOPB							
DS485N/NOPB							

# **Qualification Report**

# PDIP mold compound DMC2000HG discontinuance in AP1 Approved06/10/2014

#### **Product Attributes**

Attributes	Qual Device: LF444CN/NOPB	Qual Device: LM319N
Assembly Site	AP1	AP1
Package Family	PDIP	PDIP
Wafer Fab Supplier	GL	GL
Wafer Fab Process	BPBIFET.13.1	BPSLM.8.1

<sup>-</sup> QBS: Qual By Similarity

#### **Qualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: LF444CN/NOPB	Qual Device: LM319N
	Biased Temperature and Humidity, 85C/85%RH	1000 Hours	-	3/231/0
AC	Autoclave 121C	96 Hours	3/231/0	-
UHAST	Unbiased HAST 130C/85%RH	96 Hours	3/231/0	-
тс	Temperature Cycle, - 65/150C	500 Cycles	-	3/231/0
HTSL	High Temp Storage Bake 150C	1000 Hours	3/231/0	-

<sup>--</sup> The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/ Green/Pb-free Status: Qualified Pb-Free(SMT) and Green

TI Qualification ID: 20130502-84221

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com

<sup>-</sup> The following are equivalent HTSL options based on an activation energy of 0.7eV:150C/1k Hours, and 170C/420 Hours

<sup>-</sup> The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles